

8-BIT μ P-COMPATIBLE D/A CONVERTER

SE/NE5019

DESCRIPTION

The NE5019 is a complete 8-bit digital to analog converter subsystem on one monolithic chip. The data inputs have input latches, controlled by a latch enable pin. The data and latch enable inputs are ultra-low loading for easy interfacing with all logic systems. The latches appear transparent when the LE input is in the low state. When LE goes high, the input data present at the moment of transition is latched and retained until LE again goes low. This feature allows easy compatibility with most micro-processors.

The chip also comprises a stable voltage reference (5V nominal) and a high slew rate buffer amplifier. The voltage reference may be externally trimmed with a potentiometer for easy adjustment of full scale, while maintaining a low temperature co-efficient.

The output of the buffer amplifier may be offset so as to provide bipolar as well as unipolar operation.

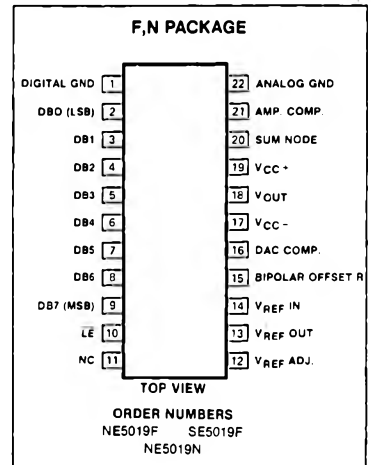
FEATURES

- 8-bit resolution
- Input latches
- Low-loading data inputs
- On-chip voltage reference
- Output buffer amplifier
- Accurate to $\pm 1/4$ LSB (.1%)
- Monotonic to 8 bits
- Amplifier and reference both short-circuit protected
- Compatible with 8085, 6800 and many other μ P's

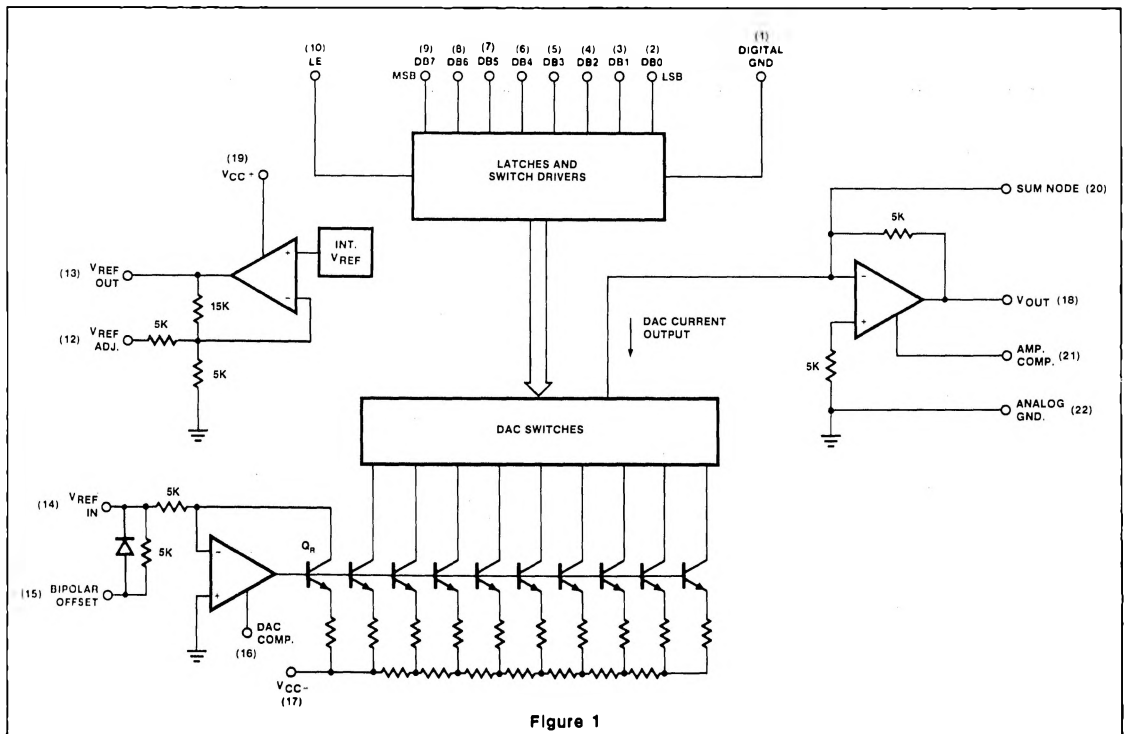
APPLICATIONS

- Precision 8-bit D/A converters
- A/D converters
- Programmable power supplies
- Test equipment
- Measuring instruments
- Analog-digital multiplication

PIN CONFIGURATION



BLOCK DIAGRAM



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ABSOLUTE MAXIMUM RATINGS

PARAMETER	RATING	UNIT
V_{CC+} Positive supply voltage	18	V
V_{CC-} Negative supply voltage	-18	V
V_{IN} Logic input voltage	0 to 18	V
V_{REFIN} Voltage at V_{REF} input	12	V
V_{REFADJ} Voltage at V_{REF} adjust	0 to V_{REF}	V
V_{SUM} Voltage at sum node	12	V
I_{REFSC} Short-circuit current to ground at V_{REF} OUT	Continuous	
I_{OUTSC} Short-circuit current to ground or either supply at V_{OUT}	Continuous	
P_D Power dissipation*		
-N package	800	mW
-F package	1000	mW
T_A Operating temperature range		
SE5019	-55 to +125	°C
NE5019	0 to +70	°C
T_{STG} Storage temperature range	-65 to +150	°C
T_{SOLD} Lead soldering temperature (10 seconds)	300	°C

*NOTES

For N package, derate at 120°C/W above 35°C

For F package, derate at 75°C/W above 75°C

DC ELECTRICAL CHARACTERISTICS $V_{CC+} = +15V$, $V_{CC-} = -15V$, SE5019, $-55^{\circ}C \leq T_A \leq 125^{\circ}C$,
 NE5019, $0^{\circ}C \leq T_A \leq 70^{\circ}C$ unless otherwise specified.¹
 Typical values are specified at 25°C

PARAMETER	TEST CONDITIONS	SE5019			NE5019			UNIT
		Min	Typ	Max	Min	Typ	Max	
Resolution		8	8	8	8	8	8	Bits
Monotonicity		8	8	8	8	8	8	Bits
Relative accuracy				± 0.1			± 0.1	%FS
V_{CC+} Positive supply voltage		11.4	15		11.4	15		V
V_{CC-} Negative supply voltage		-11.4	-15		-11.4	-15		V
$V_{IN(1)}$ Logic "1" input voltage	Pin 1 = 0V	2.0			2.0			V
$V_{IN(0)}$ Logic "0" input voltage	Pin 1 = 0V			0.8			0.8	V
$I_{IN(1)}$ Logic "1" input current	Pin 1 = 0V, $2V < V_{IN} < 18V$		0.1	10		0.1	10	μA
$I_{IN(0)}$ Logic "0" input current	Pin 1 = 0V, $-5V < V_{IN} < 0.8V$		-2.0	-10		-2.0	-10	μA
V_{FS} Full scale output voltage	Unipolar operation $V_{REF IN} = 5.000V$, $T_A = 25^{\circ}C$	9.50	9.961	10.50	9.50	9.961	10.50	V
V_{FS} Full scale output voltage	Bipolar operation $V_{REF IN} = 5.000V$, $T_A = 25^{\circ}C$	4.5	+4.961	5.5	4.5	+4.961	5.5	V
V_{ZS} Zero scale voltage		-5.040	-5.000	-4.960	-5.040	-5.000	-4.960	mV
		-30	5	+30	-30	5	+30	
I_{OS} Output short circuit current	$T_A = 25^{\circ}C$ $V_{OUT} = 0V$		15	40		15	40	mA
PSR ⁺ (out) Output power supply rejection (+)	$V_- = -15V$, $13.5V \leq V_+ \leq 16.5V$, external $V_{REF IN} = 5.000V$		.001	.01		.001	.01	%FS/ %VS
PSR ⁻ (out) Output power supply rejection (-)	$V_+ = 15V$, $-13.5V \leq V_- \leq -16.5V$, external $V_{REF IN} = 5.000V$		.001	.01		.001	.01	%FS/ %VS
TC_{FS} Full scale temperature coefficient	$V_{REF IN} = 5.000V$		20			20		ppm/°C
TC_{ZS} Zero scale temperature coefficient			5			5		ppm/°C

NOTE

1. Refer to Figure 2.

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DC ELECTRICAL CHARACTERISTICS (Cont'd) $V_{CC+} = +16V$, $V_{CC-} = -15V$, SE5019. $-55^{\circ}C \leq T_A \leq 125^{\circ}C$, NE5019. $0^{\circ}C \leq T_A \leq 70^{\circ}C$ unless otherwise specified.¹
Typical values are specified at $25^{\circ}C$

PARAMETER		TEST CONDITIONS	SE5019			NE5019			UNIT
			Min	Typ	Max	Min	Typ	Max	
I_{REF}	Reference output current	Note 8 $T_A = 25^{\circ}C$ $V_{REF OUT} = 0V$			3			3	mA
I_{REFSC}	Reference short circuit current			15	30		15	30	mA
$PSR+_{REF}$	Reference power supply rejection (+)	$V- = -15V$, $13.5V \leq V+ \leq 16.5V$, $I_{REF} = 1.0mA$		.003	.01		.003	.01	%VR / %VS
$PSR-_{REF}$	Reference power supply rejection (-)	$V+ = 15V$, $-13.5V \leq V- \leq 16.5V$, $I_{REF} = 1.0mA$		.003	.01		.003	.01	%VR / %VS
V_{REF}	Reference voltage	$I_{REF} = 1.0mA$ $T_A = 25^{\circ}C$	4.9	5.0	5.25	4.9	5.0	5.25	V
TC_{REF}	Reference voltage temperature coefficient	$I_{REF} = 1.0mA$ $T_A = 25^{\circ}C$		60			60		ppm / $^{\circ}C$
Z_{IN}	DAC V_{REFIN} input impedance	$I_{REF} = 1.0mA$ $T_A = 25^{\circ}C$	4.15	5.0	5.85	4.15	5.0	5.85	K Ω
I_{CC+}	Positive supply current	$V_{CC+} = 15V$		7	14		7	14	mA
I_{CC-}	Negative supply current	$V_{CC-} = -15V$		-10	-15		-10	-15	mA
P_D	Power dissipation	$I_{REF} = 1.0mA$, $V_{CC} = \pm 15V$		255	435		255	435	mW

NOTE

1. Refer to Figure 2.

AC ELECTRICAL CHARACTERISTICS² $V_{CC} = \pm 15V$, $T_A = 25^{\circ}C$

PARAMETER		TO	FROM	TEST CONDITIONS	SE/NE5019			UNIT
					Min	Typ	Max	
T_{SLH}	Settling time	$\pm \frac{1}{2}$ LSB	Input	All bits low to high ³		1.8		μs
T_{SHL}	Settling time	$\pm \frac{1}{2}$ LSB	Input	All bits high to low ⁴		2.3		μs
t_{plh}	Propagation delay	Output	Input	All bits switched low to high ³		300		ns
t_{phl}	Propagation delay	Output	Input	All bits switched high to low ⁴		150		ns
t_{plsb}	Propagation delay	Output	Input	1 LSB change ^{3,4}		150		ns
t_{plh}	Propagation delay	Output	$\overline{LE}$	low to high transition ⁵		300		ns
t_{phl}	Propagation delay	Output	$\overline{LE}$	high to low transition ⁶		150		ns
t_s	Set-up time	$\overline{LE}$	Input	2, 7	100			ns
t_h	Hold time	Input	$\overline{LE}$	2, 7	50			ns
t_{pw}	Latch enable pulse width			2, 7	150			ns

NOTES

2. Refer to Figure 3.

3. See Figure 6.

4. See Figure 7.

5. See Figure 8.

6. See Figure 9.

7. See Figure 10.

8. For reference currents $> 3mA$, use of an external buffer is required.

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DC PARAMETRIC TEST CONFIGURATION

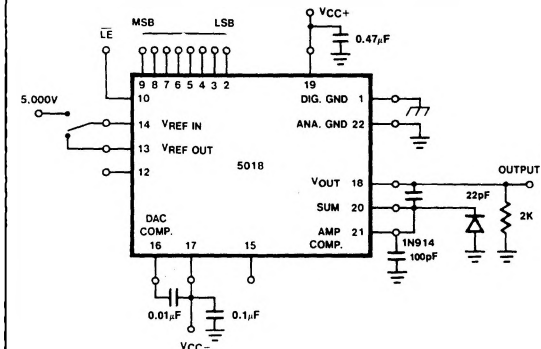


Figure 2

AC PARAMETRIC TEST CONFIGURATION

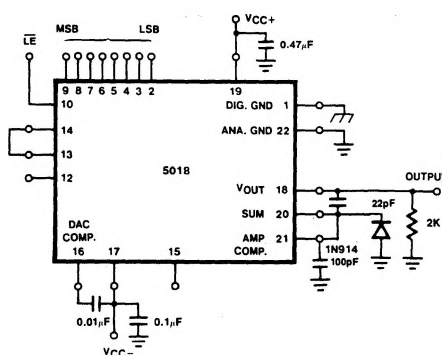


Figure 3

FULL/ZERO SCALE ADJUST—UNIPOLAR OUTPUT (0-10V)

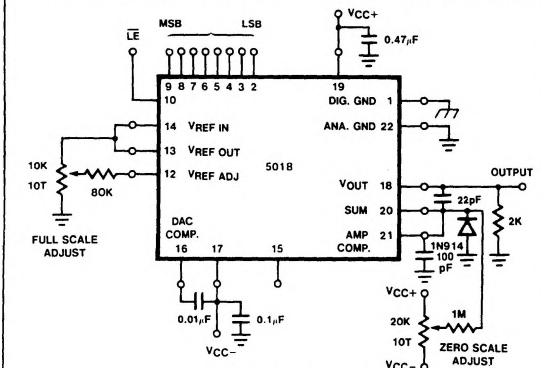


Figure 4

BIPOLAR OUTPUT OPERATION (-5 to +5V)

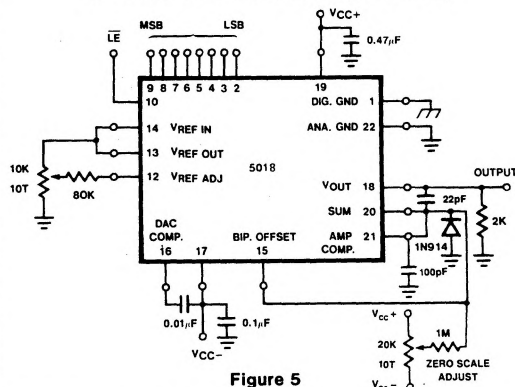


Figure 5

SETTLING TIME AND PROPAGATION DELAY, LOW TO HIGH DATA

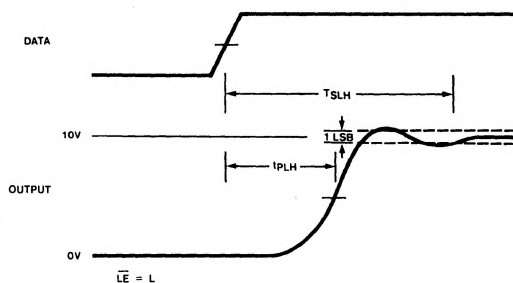


Figure 6

SETTLING TIME AND PROPAGATION DELAY, HIGH TO LOW DATA

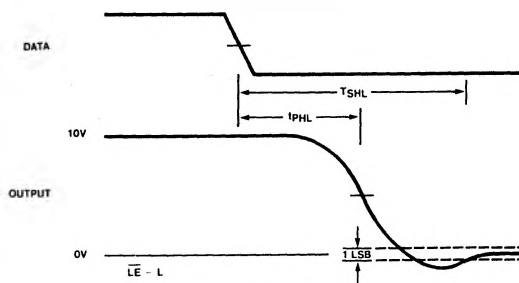
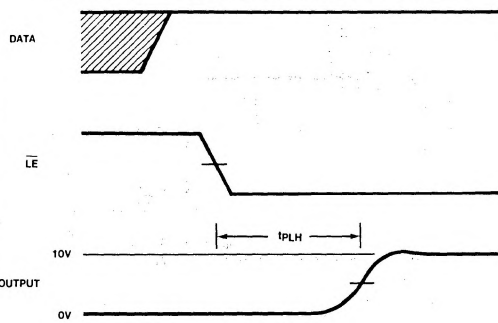
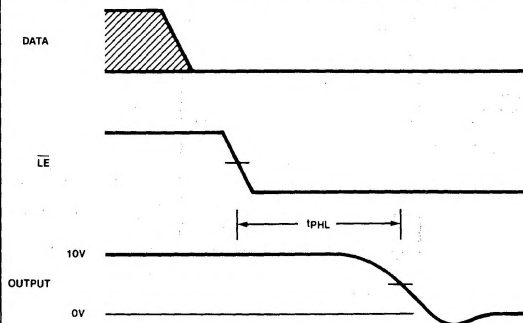
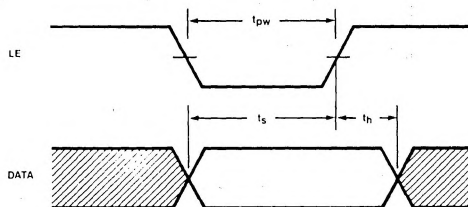


Figure 7

8-BIT μ P-COMPATIBLE D/A CONVERTER**SE/NE5019****PROPAGATION DELAY, LATCH ENABLE TO OUTPUT****Figure 8****PROPAGATION DELAY, LATCH ENABLE TO OUTPUT****Figure 9****LATCH ENABLE PULSE WIDTH, SET-UP AND HOLD TIMES****Figure 10**